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## **Supporting Information**

## High performance and Self-Powered Photodetector Based on

## Se/CsPbBr<sub>3</sub> Heterojunction

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Fig. S1 SEM images of (a) CsPbBr3 and (b-f) Se/CsPbBr3 at low and high magnification.



Fig. S2 (a) The I-V curves of  $CsPbBr_3 PD$  at dark and 550 nm, (b) I-t curves of  $CsPbBr_3 PD$  under 550 nm at 0.1 V bias.

In order to calculate the noise equivalent power (NEP) of the Se/CsPbBr<sub>3</sub> device, we measured the noise current of our detectors under a bias of 0.5, 1 and 2 V at different frequency (1-1000 Hz). The noise power spectrum is shown on Fig. S3. With a slope of approximately 1, the noise power spectrum of Se/CsPbBr<sub>3</sub> PD exhibits high 1/f dependency, which mostly restricts detectivity at low-frequency because of the flicker noise. At 1 Hz, S (f = 1Hz ) is  $9.34 \times 10^{-28}$ ,  $2.97 \times 10^{-26}$ ,  $1.24 \times 10^{-25}$  A<sup>2</sup> Hz<sup>-1</sup> at bias of 0.5, 1 and 2 V. The responsivity of Se/CsPbBr<sub>3</sub> PD is 0.8, 1.2 and 3.2 AW<sup>-1</sup> with the different bias at 550 nm, respectively. Then, the NEP of Se/CsPbBr<sub>3</sub> PD is calculated to be 1.21  $\times 10^{-13}$ ,  $1.43 \times 10^{-13}$  and  $1.12 \times 10^{-13}$  W Hz<sup>-1/2</sup> at the wavelength of 550 nm under a modulation frequency of 1 Hz at bias of 0.5, 1 and 2 V, which is lower sensitivity than the reported photodetectors (PbS/CsPbBr<sub>3</sub> PD of 0.14 pW Hz<sup>-1/2</sup>, CsPbBr<sub>3</sub> PD of 1 pW Hz<sup>-1/2</sup>, MoS<sub>2</sub> PD of 1.8 pW Hz<sup>-1/2</sup>) <sup>55-57</sup>. According to the equation:  $D^* = \frac{R\sqrt{AB}}{I_n} = \frac{\sqrt{AB}}{NEP}$ , where I<sub>n</sub> is the total noise current,

A is the effective area of device, B is the measurement bandwidth. The specific detectivity D\* is

2.61, 2.21 and 2.90×10  $^{10}$  Jones at bias of 0.5, 1 and 2 V. The parameter are listed in Table S1 and S2.



Fig. S3 Noise power density as a function of bias voltage of (a) Se-MT PD and (b) Se/CsPbBr<sub>3</sub> PD.

Bias	$S(1 \text{ Hz})(\text{A}^2 \text{ Hz}^{-1})$	R(A W <sup>-1</sup> )	NEP (W Hz <sup>-1/2</sup> )	D* (Jones)
0.5 V	8.26×10 <sup>-26</sup>	0.1	2.87 ×10 <sup>-12</sup>	1.10×10 <sup>9</sup>
1 V	3.10×10 <sup>-25</sup>	0.6	9.27×10 <sup>-13</sup>	3.41×10 <sup>9</sup>
2 V	9.32×10 <sup>-25</sup>	1.2	8.05×10 <sup>-13</sup>	3.93×10 <sup>9</sup>

Table S1 The S(1 Hz), NEP and D\* of Se-MT PD at 0.5, 1 and 2 V

Table S2 The S(1 Hz), NEP and $D^*$ of Se/CsPbBr <sub>3</sub> PD at 0.5, 1 a
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Bias	$S(1 Hz)(A^2 Hz^{-1})$	R(A W <sup>-1</sup> )	NEP (W Hz <sup>-1/2</sup> )	D* (Jones)
0.5 V	9.34×10 <sup>-28</sup>	0.8	1.21 ×10 <sup>-13</sup>	2.61×10 <sup>10</sup>
1 V	2.97×10 <sup>-26</sup>	1.2	1.43×10 <sup>-13</sup>	2.21×10 <sup>10</sup>
2 V	1.24×10 <sup>-25</sup>	3.2	1.12×10 <sup>-13</sup>	2.90×10 <sup>10</sup>



Fig. S4 The I-t curves of the Se/CsPbBr<sub>3</sub> PD after 2 months.